

**Notice of References Cited**

Application/Control No.

10/560,152

Applicant(s)/Patent Under  
Reexamination  
TANAKA ET AL.

Examiner

MARC DAZENSKI

Art Unit

2621

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*	A	US-7,099,239	08-2006	Ogikubo, Takahiko	369/30.23
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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